

Search Notes



Application/Control No.

10/562,652

Examiner

Dawn Garrett

Applicant(s)/Patent under Reexamination

OSHIYAMA ET AL.

Art Unit

1774

SEARCHED

Class	Subclass	Date	Examiner
428	690	3/25/07	DS
428	917		
313	504		
313	506		
(see EAST search printout)			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Inventor Name search	3/25/07	DS
EAST search (see printout)	3/25/07 AND 3/26/07	DS
STIC search (formulas 1-12) (see attached)	8/31/07	DS
EAST search (see attached)	8/22/07 AND 10/2/07	DS